



MPPC[®]

Multi-Pixel **Photon** Counter

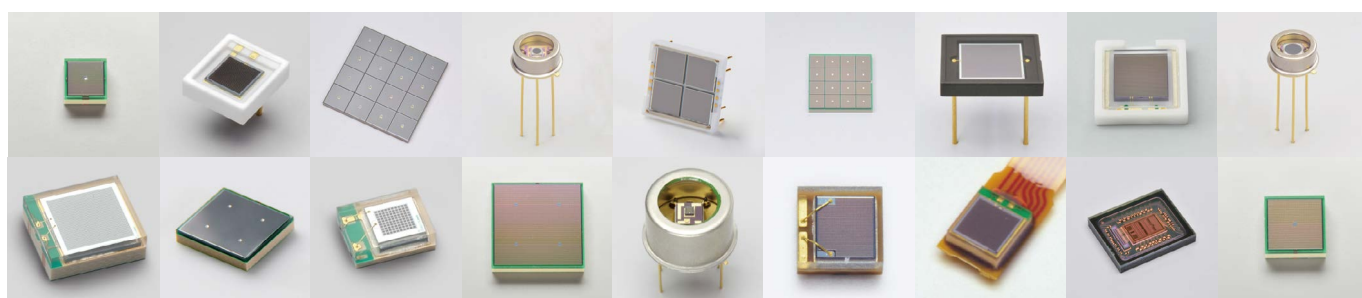
Photosensors with excellent photon-counting capability

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What is MPPC[®] (SiPM)?



The MPPC (multi-pixel photon counter) is a type of photosensor called SiPM (silicon photomultiplier). It is a photon-counting device using multiple APD (avalanche photodiode) pixels operating in Geiger mode. Although essentially an opto-semiconductor device, it has excellent light receiving capability and can be used in various applications for detecting extremely weak light at the photon counting level. The MPPC operates on low voltage and features high gain, high photon detection efficiency, high-speed response, excellent time resolution, and wide spectral response range. It achieves the high-level performance required in photon counting. It is also immune to magnetic fields, highly resistant to mechanical shocks and the like, and will not suffer from “burn-in” by incident light saturation, which are advantages unique to solid-state devices.



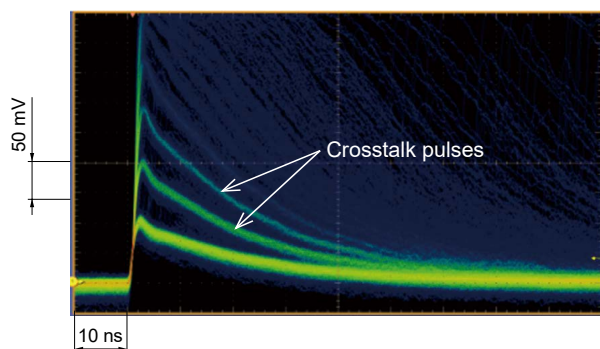
• Features of MPPC

When an MPPC detects photons, the output may contain false signals, called afterpulse and crosstalk that are separate from the output pulses of the incident photons, and heat-derived noise called dark counts. Hamamatsu MPPC maintains high photon detection efficiency while featuring low afterpulse, low crosstalk, and low dark count.

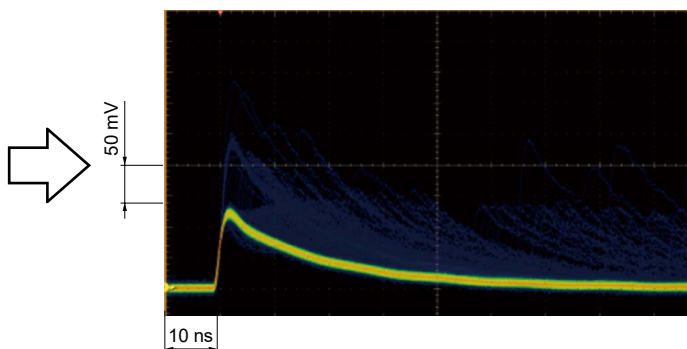
FEATURE 1 Low crosstalk

The pixel that detects photons may affect other pixels, making them produce pulses separate from output pulses. This phenomenon is called crosstalk. MPPC employs a structure that suppresses the occurrence of crosstalk.

■ Previous product (3 × 3 mm, 50 μm pitch)



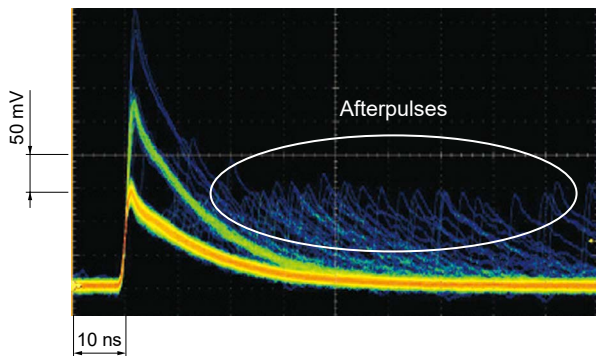
■ Current product S13360-3050CS (3 × 3 mm, 50 μm pitch)



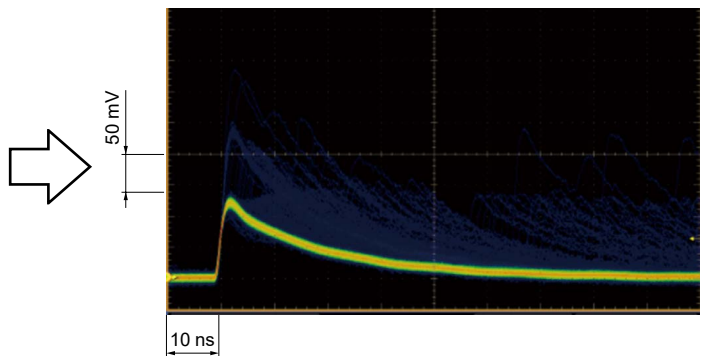
FEATURE 2 Low afterpulses

While an MPPC detects photons, delayed signals may be output separately from the output pulses. These signals are called afterpulses. Hamamatsu MPPC has low afterpulses.

■ Previous product (3 × 3 mm, 50 μm pitch)



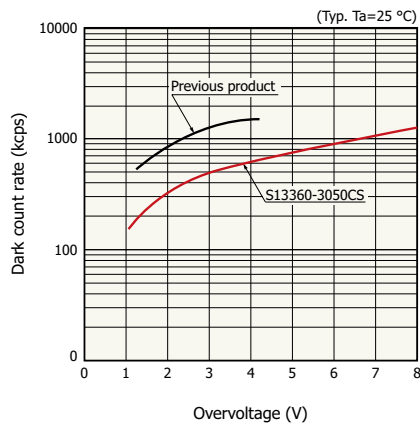
■ Current product S13360-3050CS (3 × 3 mm, 50 μm pitch)



FEATURE 3 Low dark count, high gain, high photon detection efficiency

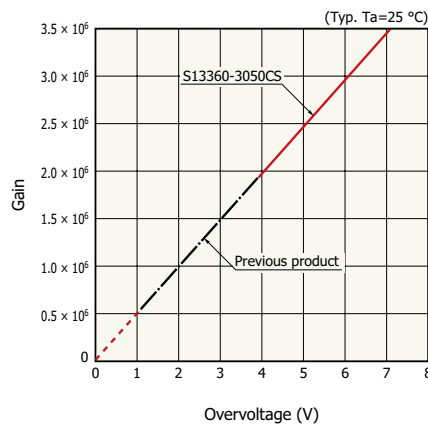
Improvements in materials and wafer process technology have reduced the dark count down to approximately half that of previous products.

■ Dark count rate vs. overvoltage



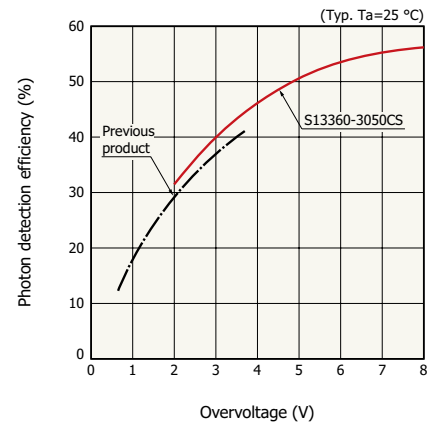
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■ Gain vs. overvoltage



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■ Photon detection efficiency vs. overvoltage

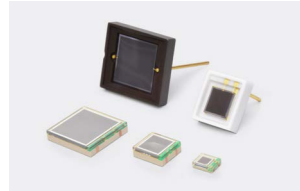


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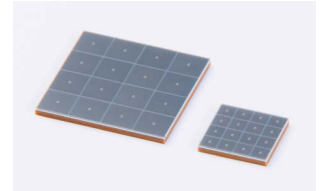
MPPC lineup

Hamamatsu offers a lineup of MPPCs that support a spectral range from vacuum ultraviolet (VUV) to near infrared (NIR), and also offers various element types, including multi-channel and thermoelectric cooling.


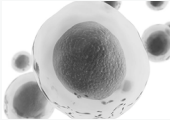

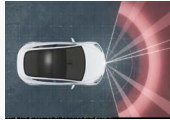






Choose from products suitable for various applications, including academic or research purposes, analytical equipment, PET scanners, and LiDAR.



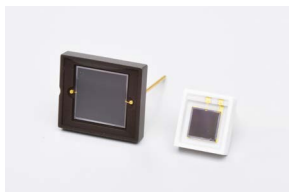
Single-channel MPPC



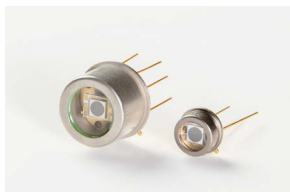
Multi-channel MPPC

Applications Measurement wavelength	Academic research 	Measuring instruments (Flow cytometers, Microscopes, etc.) 	PET scanners 	LiDAR 
VUV/UV	P.26 For academic research experiments			
VIS	P.9~ For wide dynamic range S14160 series 		P.12 For PET scanners S14160 / S14161 series 	
	P.13~ For precision measurement S13360 / S13362 series 			
	P.19~ For precision measurement (TSV type) S13360 / S13361 series 			
VIS to NIR		P.21~ For visible light S14420 / S14422 series 		
NIR				P.25~ For near infrared S15639-1325PS S16786-0515WM 

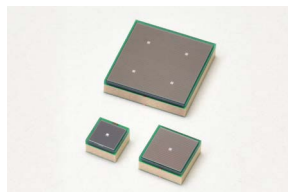
• Package option



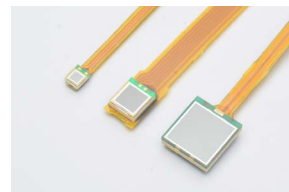
Ceramic package




Metal package



Glass epoxy package

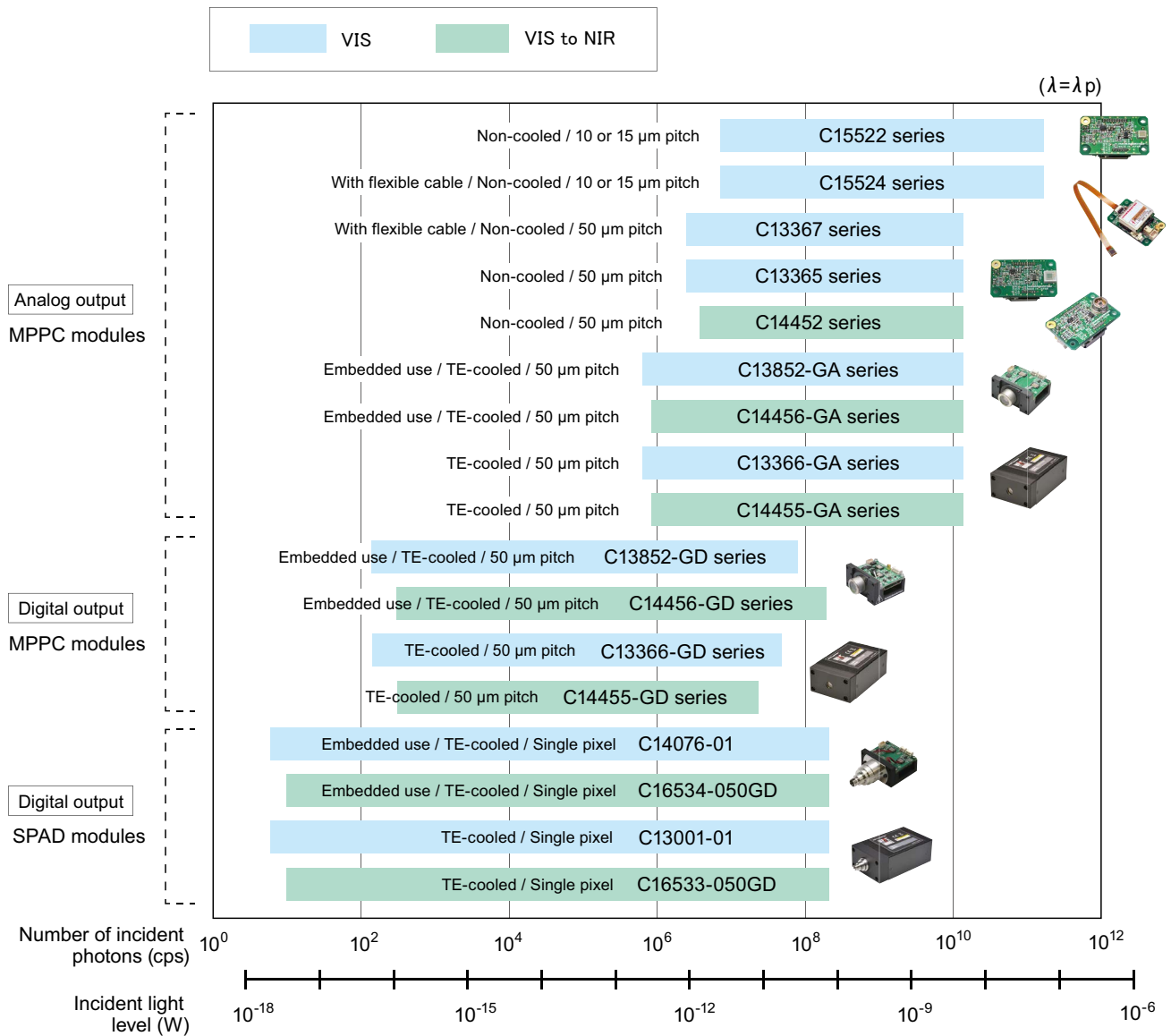


With flexible cable

Contents Measurement wavelength	MPPC			Package options				Module type (MPPC module) 
	Page no.	Type no.	Channel type	Ceramic package	Metal package	Glass epoxy package	With flexible cable	
VUV/UV	Please consult us about VUV/UV MPPC.							
VIS	P.9	S14160 series	Single-channel			✓		✓
	P.12	S14161 series	Multi-channel			✓		
	P.13	S13360 series	Single-channel	✓	✓	✓	✓	✓
	P.17	S13362 series	<div>TE-cooled</div> Single-channel		✓			✓
	P.19	S13360 series (TSV type)	Single-channel			✓		
		S13361 series	Multi-channel			✓		✓
VIS to NIR	P.21	S14420 series	Single-channel		✓			✓
	P.23	S14422 series	<div>TE-cooled</div> Single-channel		✓			✓
NIR	P.25	S15639-1325PS	Single-channel			✓		
		S16786-0515WM				✓		

MPPC modules / SPAD modules lineup

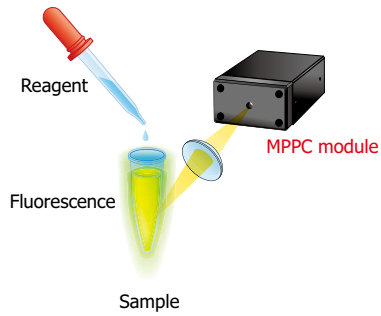
MPPC modules and SPAD modules are light detection modules with a built-in MPPC or SPAD. In addition to the detector, it is equipped with an amplifier and bias circuit, so all it needs is a power supply to perform measurement. These modules can be integrated into various devices or used for simple evaluation. We offer various product types, including low dark count cooled modules, uncooled modules with a temperature compensation function, and array modules with multi-channel MPPC. We also provide custom-made products to meet customer specifications.



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• Application examples

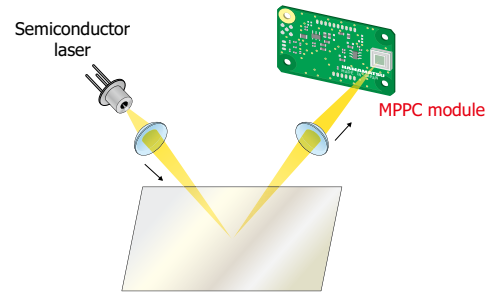
Fluorescence measurement



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Major characteristics:
High photon detection efficiency, low afterpulse

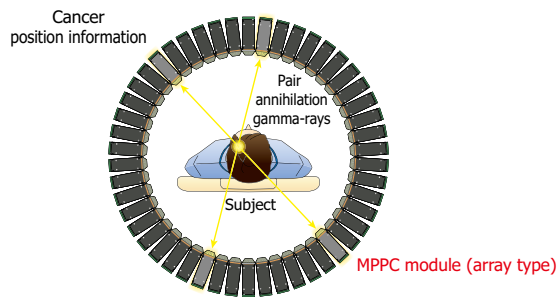
Surface inspection



KACCC1155EA

Major characteristics:
High-speed response, wide dynamic range

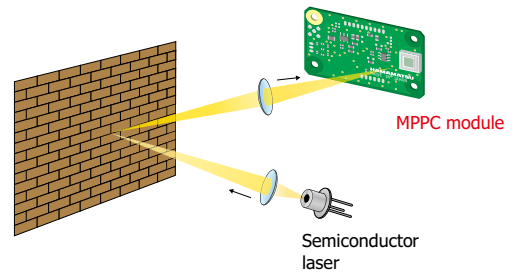
Scintillation measurement



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Major characteristics:
High photon detection efficiency, wide dynamic range

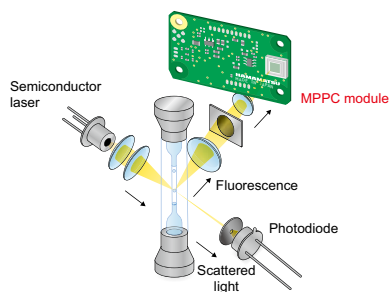
Distance measurement



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Major characteristics:
High-speed response, wide dynamic range

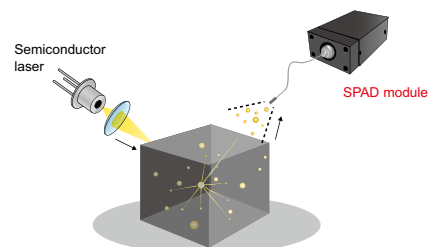
Flow cytometry



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Major characteristics:
Wide dynamic range, high photon detection efficiency

Particle measurement



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Major characteristics:
High photon detection efficiency, low afterpulse



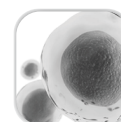
Product information

- VIS MPPC
- VIS to NIR MPPC
- NIR MPPC

VIS MPPC

For wide dynamic range**S14160 series**

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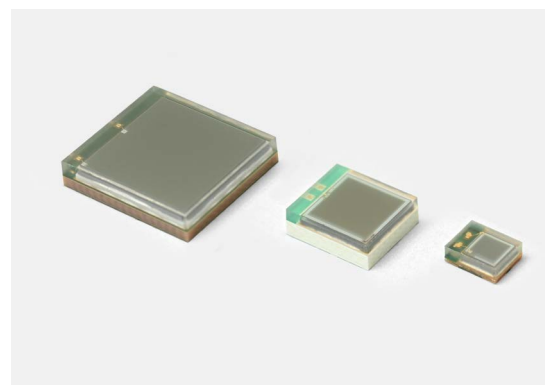
MEASUREMENT

► FEATURES

- Small pixel pitch (10 μm / 15 μm)
- Wide dynamic range
- Low operating voltage ($V_{BR}=38\text{ V typ.}$)

► APPLICATIONS

- High energy physics experiments
- Flow cytometers
- DNA sequencers
- Environmental analysis

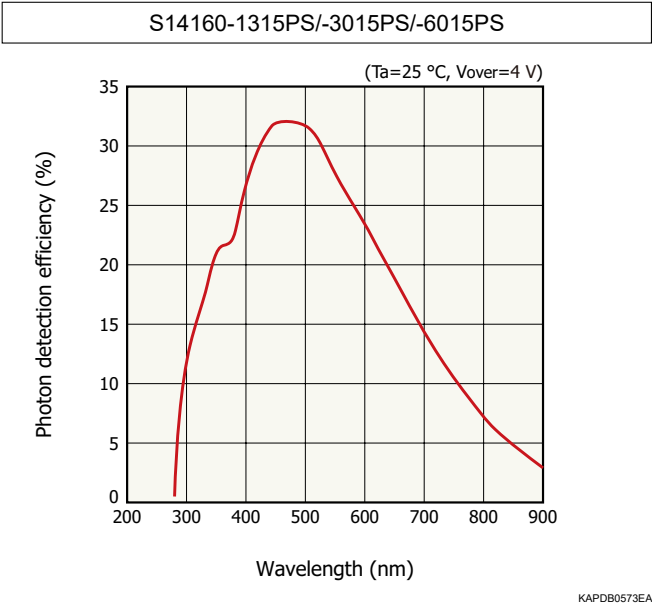
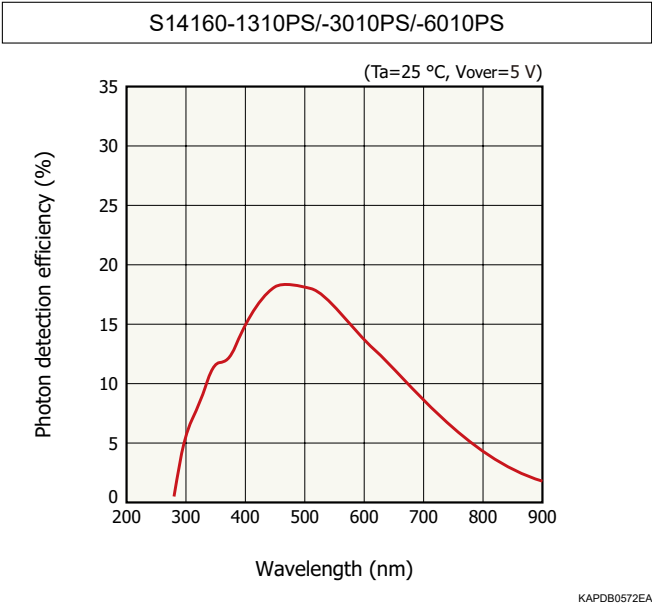
**■ Structure**

Type no.		Number of channel (ch)	Package	Pixel pitch (μm)	Effective photosensitive area (mm)	Number of pixels	Fill factor (%)
S14160	-1310PS	1	Surface mount type	10	1.3 \times 1.3	16663	31
	-3010PS				3.0 \times 3.0	89984	
	-6010PS				6.0 \times 6.0	359011	
	-1315PS			15	1.3 \times 1.3	7284	49
	-3015PS				3.0 \times 3.0	39984	
	-6015PS				6.0 \times 6.0	159565	

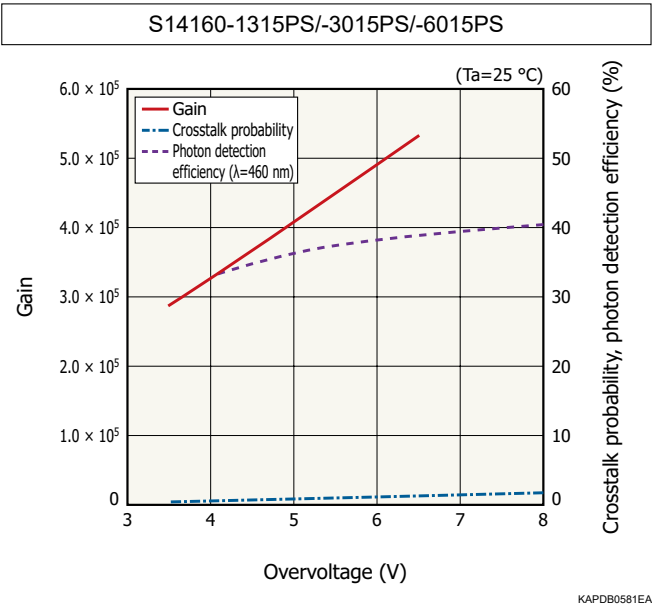
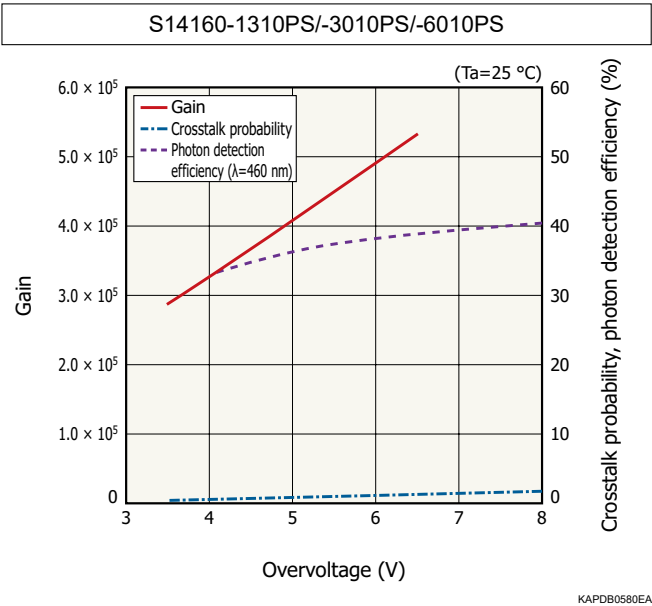
■ Electrical and optical characteristics (Typ. $T_a=25\text{ }^\circ\text{C}$, unless otherwise noted)

Type no.		Photon detection efficiency $\lambda=\lambda_p$ (%)	Breakdown voltage (V)	Terminal capacitance (pF)	Dark count	
					Typ. (kcps)	Max. (kcps)
S14160	-1310PS	18	38 ± 3	100	120	360
	-3010PS			530	700	2100
	-6010PS			2200	3000	10000
	-1315PS	32		100	120	360
	-3015PS			530	700	2100
	-6015PS			2200	3000	10000

■ Photon detection efficiency vs. wavelength (typical example)



■ Gain, crosstalk probability, photon detection efficiency vs. overvoltage (typical example)



Module type

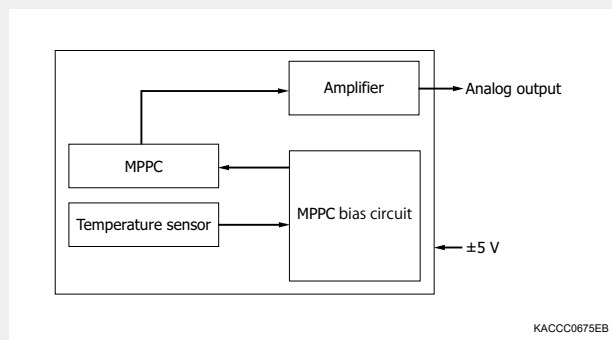
MPPC module C15522 series

■ Features

- Built-in VIS MPPC
(S14160 series: 10 μm / 15 μm pixel pitch)
- Built-in temperature compensation circuit
- Analog output



■ Block diagram



Type no.		Output	Type	Built-in MPPC			
				Type no.	Pixel pitch (μm)	Photosensitive area (mm)	Number of pixels
C15522	-1310SA	Analog	Non-cooled	S14160-1310PS	10	1.3 \times 1.3	16663
	-3010SA			S14160-3010PS		3.0 \times 3.0	89984
	-1315SA			S14160-1315PS	15	1.3 \times 1.3	7284
	-3015SA			S14160-3015PS		3.0 \times 3.0	39984

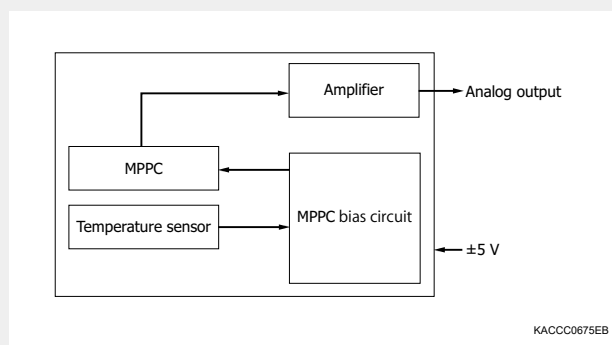
MPPC module C15524 series

■ Features

- Equipped with VIS MPPC
(S14160 series: 10 μm / 15 μm pixel pitch)
- With a flexible cable
- Built-in temperature compensation circuit
- Analog output



■ Block diagram



Type no.		Output	Type	Built-in MPPC			
				Type no.	Pixel pitch (μm)	Photosensitive area (mm)	Number of pixels
C15524	-1310SA	Analog	Non-cooled	S14160-1310PS	10	1.3 \times 1.3	16663
	-3010SA			S14160-3010PS		3.0 \times 3.0	89984
	-1315SA			S14160-1315PS	15	1.3 \times 1.3	7284
	-3015SA			S14160-3015PS		3.0 \times 3.0	39984

For PET scanners

S14160 / S14161 series

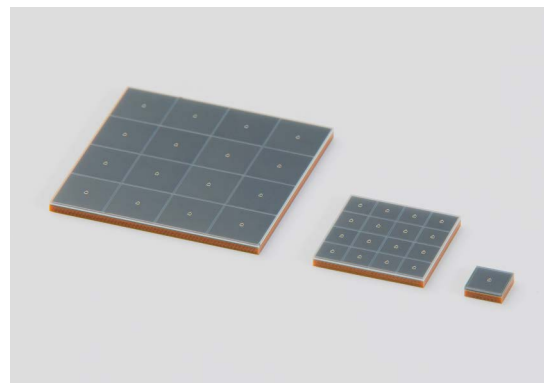


FEATURES

- Higher PDE (50% at λ_p , $V_{op}=V_{BR} + 2.7$ V)
- Small dead space in effective photosensitive area
- Low operating voltage ($V_{BR}=38$ V typ.)
- Resistance to a magnetic field environment

APPLICATIONS

- PET scanners
- Radiation monitors



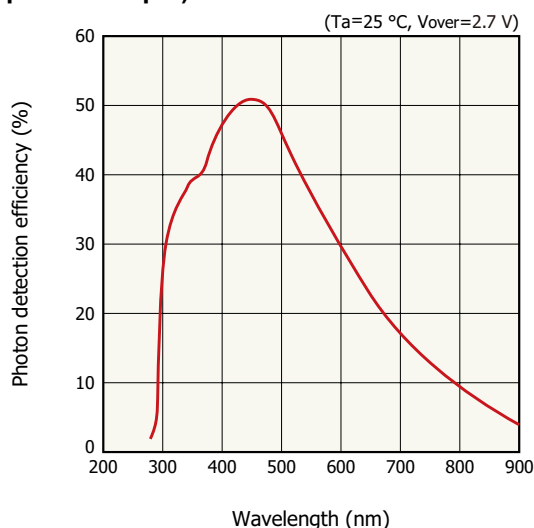
Structure

Type no.	Number of channels (ch)	Package	Pixel pitch (μm)	Effective photosensitive area/ch (mm)	Number of pixels/ch	Fill factor (%)
S14160	-3050HS	Glass epoxy	50	3.0×3.0	3531	74
	-4050HS			4.0×4.0	6331	
	-6050HS			6.0×6.0	14331	
S14161	-3050HS-04			3.0×3.0	3531	
	-3050HS-08			3.0×3.0	3531	
	-4050HS-06			4.0×4.0	6331	
	-6050HS-04			6.0×6.0	14331	

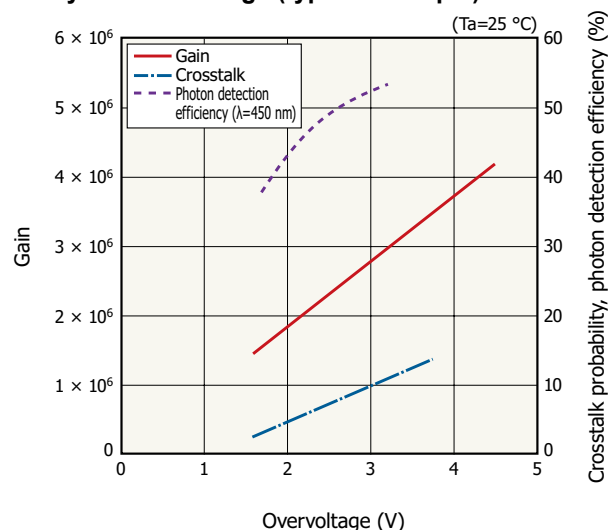
Electrical and optical characteristics (Typ. $T_a=25^\circ\text{C}$, unless otherwise noted)

Type no.	Photon detection efficiency $\lambda=\lambda_p$ (%)	Breakdown voltage V_{BR} (V)	Terminal capacitance C_t (pF)	Dark current	
				Typ. (μA)	Max. (μA)
S14160/ S14161	-3050HS	38	500	0.6	1.8
	-3050HS-04				
	-3050HS-08				
	-4050HS		900	1.1	3.3
	-4050HS-06				
	-6050HS		2000	2.5	7.5
	-6050HS-04				

Photon detection efficiency vs. wavelength (typical example)



Gain, crosstalk probability, photon detection efficiency vs. overvoltage (typical example)



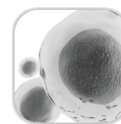
VIS MPPC

For precision measurement

S13360 series



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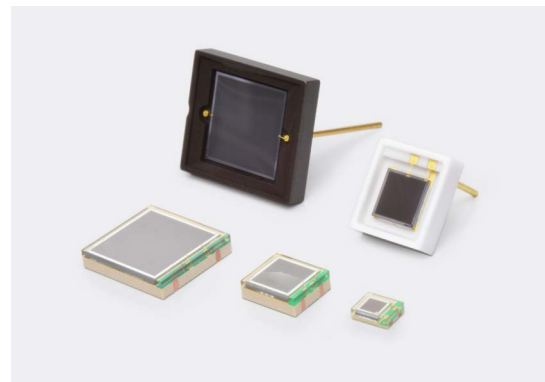
MEASUREMENT

FEATURES

- Wide variety of products
- Operates at room temperature

APPLICATIONS

- Fluorescence measurement
- Laser microscopes
- Flow cytometers
- DNA sequencers
- Environmental analysis
- Academic research



Structure

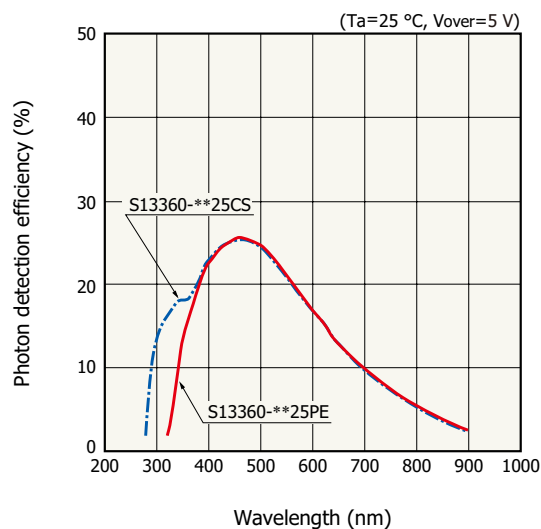
Type no.		Number of channel (ch)	Package	Pixel pitch (μm)	Effective photosensitive area (mm)	Number of pixels	Fill factor (%)
S13360	-1325PE	1	Glass epoxy	25	1.3 × 1.3	2668	47
	-3025CS		Ceramic		3.0 × 3.0	14400	
	-3025PE		Glass epoxy				
	-6025CS		Ceramic		6.0 × 6.0	57600	
	-6025PE		Glass epoxy				
	-1350PE		Glass epoxy	50	1.3 × 1.3	667	74
	-3050CS		Ceramic		3.0 × 3.0	3600	
	-3050PE		Glass epoxy				
	-6050CS		Ceramic		6.0 × 6.0	14400	
	-6050PE		Glass epoxy				
	-1375PE		Glass epoxy	75	1.3 × 1.3	285	82
	-3075CS		Ceramic		3.0 × 3.0	1600	
	-3075PE		Glass epoxy				
	-6075CS		Ceramic		6.0 × 6.0	6400	
	-6075PE		Glass epoxy				

■ Electrical and optical characteristics (Typ. Ta=25 °C , unless otherwise noted)

Type no.		Photon detection efficiency λ=λp (%)	Breakdown voltage (V)	Terminal capacitance (pF)	Dark count	
					Typ. (kcps)	Max. (kcps)
S13360	-1325PE	25	53 ± 5	60	70	210
	-3025CS			320	400	1200
	-3025PE					
	-6025CS			1280	1600	5000
	-6025PE					
	-1350PE	40		60	90	270
	-3050CS			320	500	1500
	-3050PE					
	-6050CS			1280	2000	6000
	-6050PE					
	-1375PE	50		60	90	270
	-3075CS			320	500	1500
	-3075PE					
	-6075CS			1280	2000	6000
	-6075PE					

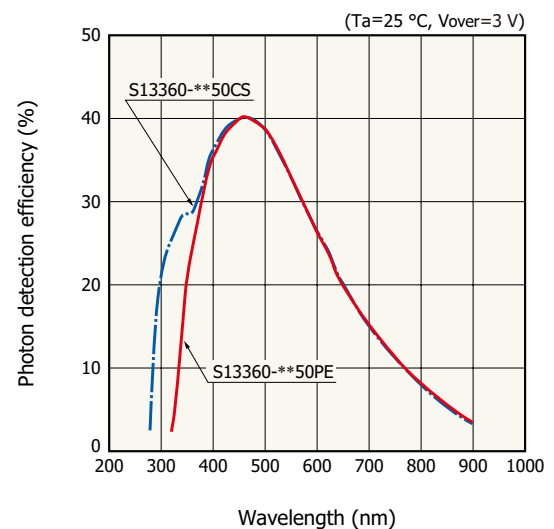
■ Photon detection efficiency vs. wavelength (typical example)

Pixel pitch: 25 μm

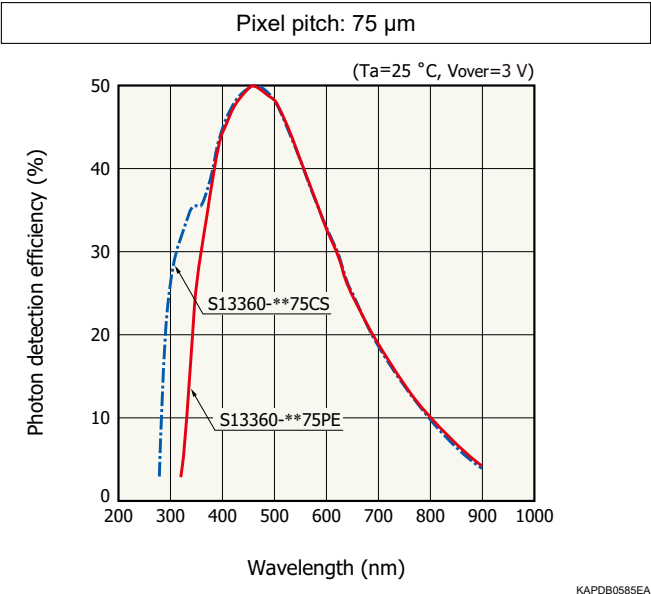


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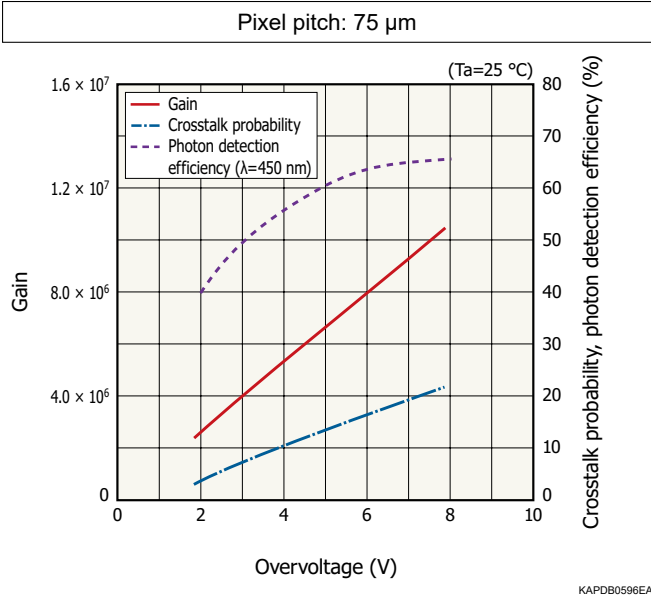
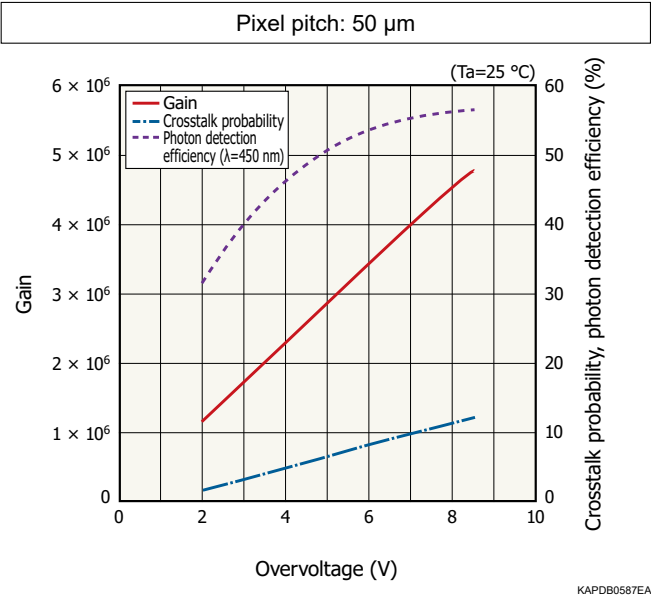
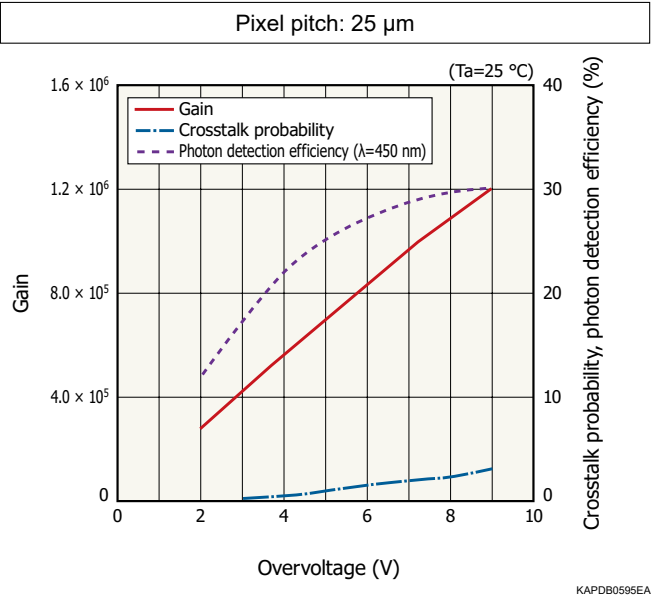
Pixel pitch: 50 μm



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■ Gain, crosstalk probability, photon detection efficiency vs. overvoltage (typical example)



► Module type

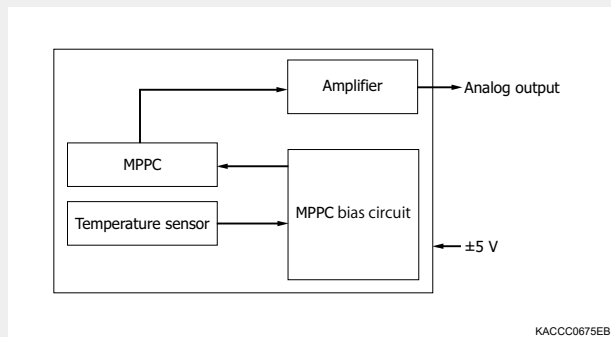
MPPC module C13365 series

■ Features

- Built-in VIS MPPC (S13360 series)
- Built-in temperature compensation circuit
- Analog output



■ Block diagram



Type no.		Output	Type	Built-in MPPC			
				Type no.	Pixel pitch (μm)	Photosensitive area (mm)	Number of pixels
C13365	-1350SA	Analog	Non-cooled	-	50	1.3 × 1.3	667
	-3050SA			S13360-3050CS		3.0 × 3.0	3600

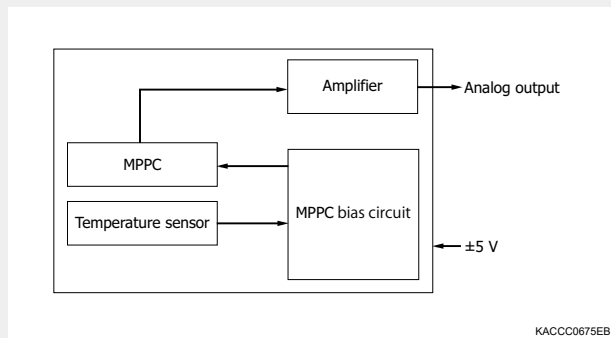
MPPC module C13367 series

■ Features

- Equipped with VIS MPPC (S13360 series) with a flexible cable
- Built-in temperature compensation circuit
- Analog output



■ Block diagram



Type no.		Output	Type	Built-in MPPC			
				Type no.	Pixel pitch (μm)	Photosensitive area (mm)	Number of pixels
C13367	-1350EA	Analog	Non-cooled	S13360-1350PE	50	1.3 × 1.3	667
	-3050EA			S13360-3050PE		3.0 × 3.0	3600
	-6050EA			S13360-6050PE		6.0 × 6.0	14400

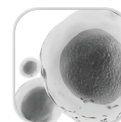
VIS MPPC

For precision measurement (cooled type)

S13362 series



ACADEMIC



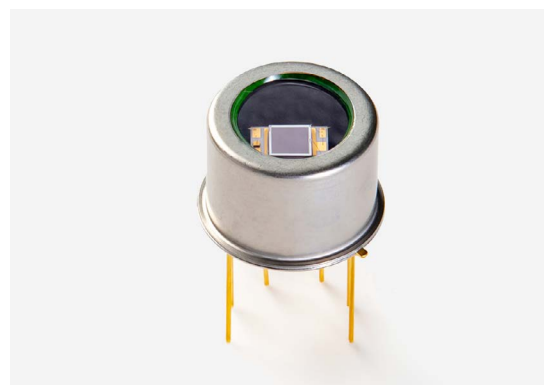
MEASUREMENT

FEATURES

- Operation possible with simple readout circuit
- Low dark count: 1/20 that of non-cooled type ($T_{chip} = -10\text{ }^{\circ}\text{C}$)

APPLICATIONS

- Scattered light measurement
- Fluorescence measurement
- Flow cytometers
- Laser microscopes



Structure

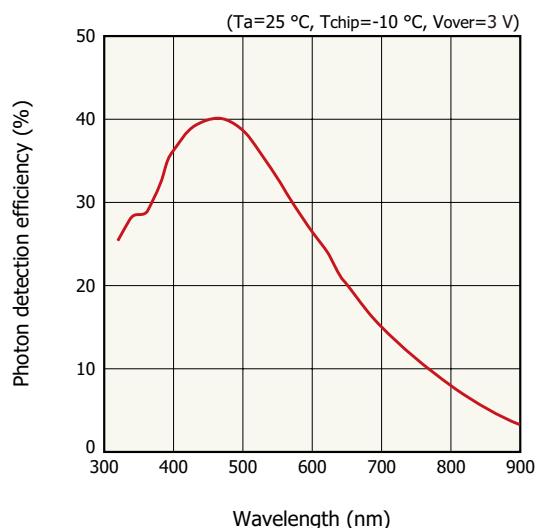
Type no.		Number of channel (ch)	Package	Pixel pitch (μm)	Effective photo-sensitive area (mm)	Number of pixels	Fill factor (%)	Cooling
S13362	-1350DG	1	Metal (TO-8)	50	1.3×1.3	667	74	Two-stage TE-cooled
	-3050DG				3.0×3.0	3600		

Electrical and optical characteristics (Typ. $T_a = 25\text{ }^{\circ}\text{C}$, $T_{chip} = -10\text{ }^{\circ}\text{C}$, unless otherwise noted)

Type no.		Photon detection efficiency $\lambda = \lambda_p$ (%)	Breakdown voltage (V)	Terminal capacitance (pF)	Dark count		Recommended TE-cooler temperature ($^{\circ}\text{C}$)	Thermistor resistance (k Ω)	Thermistor B constant (K)
					Typ. (kcps)	Max. (kcps)			
S13362	-1350DG	40	51.1 ± 5	60	5	25	-10	9*1	3410^{*2}
	-3050DG			320	13	72			

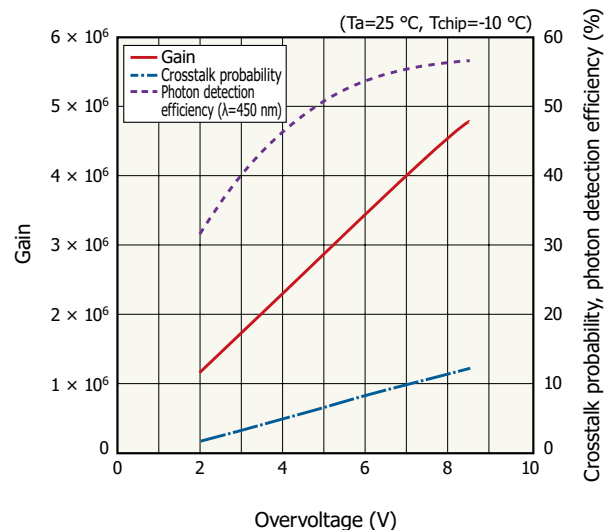
*1: Thermistor temperature = $25\text{ }^{\circ}\text{C}$ *2: $T_1 = 25\text{ }^{\circ}\text{C}$, $T_2 = 50\text{ }^{\circ}\text{C}$

Photon detection efficiency vs. wavelength (typical example)



KAPDB0604EA

Gain, crosstalk probability, photon detection efficiency vs. overvoltage (typical example)



KAPDB0589EB

► Module type

MPPC module C13366/C13852 series

■ Features

- Built-in VIS MPPC (S13362 series: cooled type)
- Built-in temperature control function
- Low dark count
- Compact and lightweight (C13852 series)
- Analog output / digital output types available

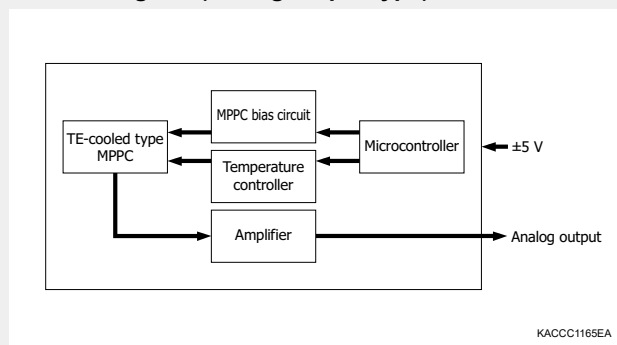


C13366 series
(for evaluation)

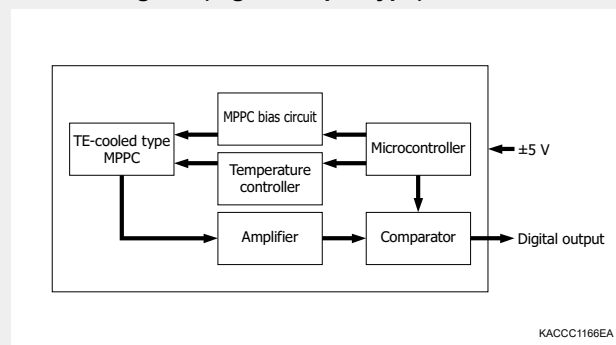


C13852 series
(for embedded use)

■ Block diagram (analog output type)



■ Block diagram (digital output type)



Type no.		Output	Type	Built-in MPPC			
				Type no.	Pixel pitch (μm)	Photosensitive area (mm)	Number of pixels
C13366	-1350GA	Analog	TE-cooled	S13362-1350DG	50	1.3 × 1.3	667
	-3050GA			S13362-3050DG		3.0 × 3.0	3600
	-1350GD	Digital		S13362-1350DG		1.3 × 1.3	667
	-3050GD			S13362-3050DG		3.0 × 3.0	3600
C13852	-1350GA	Analog	TE-cooled	S13362-1350DG	50	1.3 × 1.3	667
	-3050GA			S13362-3050DG		3.0 × 3.0	3600
	-1350GD	Digital		S13362-1350DG		1.3 × 1.3	667
	-3050GD			S13362-3050DG		3.0 × 3.0	3600

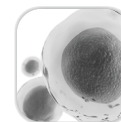
VIS MPPC

For precision measurement (TSV type)

S13360 / S13361 series



ACADEMIC



MEASUREMENT



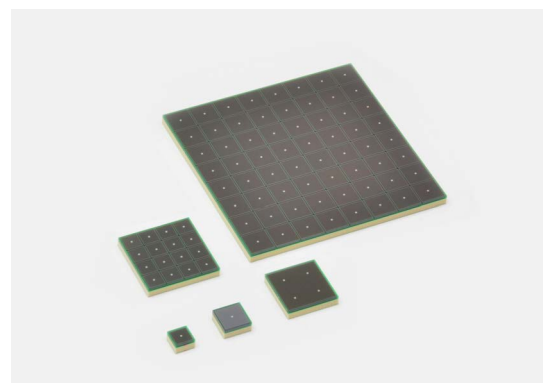
PET

► FEATURES

- Compact chip size package as a result of eliminating dead space

► APPLICATIONS

- Space research
- High energy physics experiments
- PET scanners
- Environmental analysis

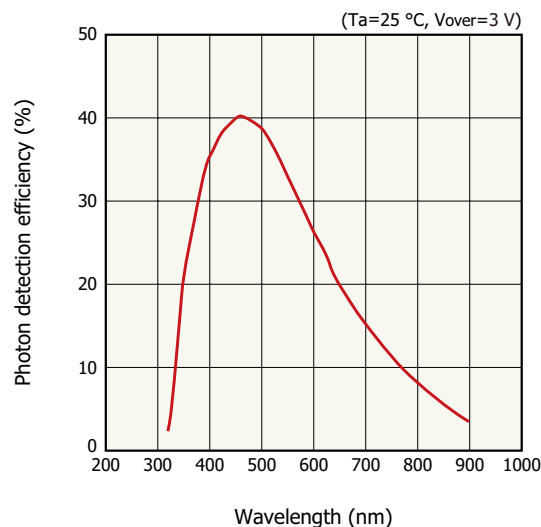
**■ Structure**

Type no.		Number of channels (ch)	Package	Pixel pitch (μm)	Effective photosensitive area /ch (mm)	Number of pixels/ch	Fill factor (%)	
S13360	-2050VE	1	Glass epoxy	50	2.0 × 2.0	1584	74	
	-3050VE				3.0 × 3.0	3584		
	-6050VE				6.0 × 6.0	14336		
S13361	-2050NE-08	8 × 8	Glass epoxy		2.0 × 2.0	1584		
	-2050AE-08		Glass epoxy With connector					
	-3050NE-04	4 × 4	Glass epoxy		3.0 × 3.0	3584		
	-3050AE-04		Glass epoxy With connector					
	-3050NE-08	8 × 8	Glass epoxy					
	-3050AE-08		Glass epoxy With connector					

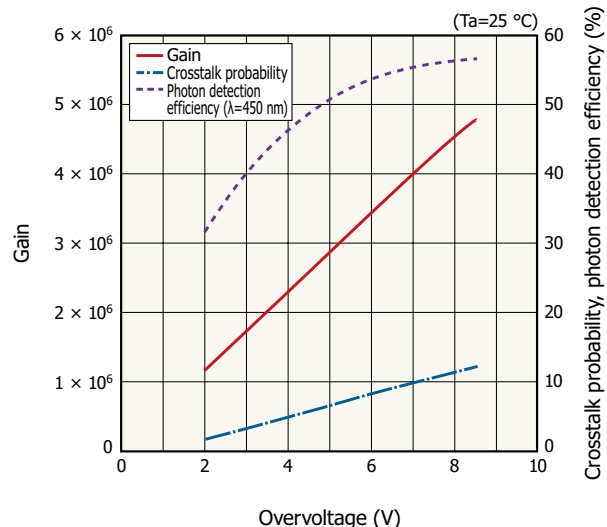
■ Electrical and optical characteristics (Typ. Ta=25 °C , unless otherwise noted)

Type no.		Photon detection efficiency $\lambda=\lambda_p$ (%)	Breakdown voltage (V)	Terminal capacitance (pF)	Dark count	
					Typ. (kcps)	Max. (kcps)
S13360	-2050VE	40	53 ± 5	140	300	900
	-3050VE			320	500	1500
	-6050VE			1300	2000	6000
S13361	-2050NE-08			140	300	900
	-2050AE-08			320	500	1500
	-3050NE-04					
	-3050AE-04					
	-3050NE-08					
	-3050AE-08					

■ Photon detection efficiency vs. wavelength (typical example)



■ Gain, crosstalk probability, photon detection efficiency vs. overvoltage (typical example)



► Module type

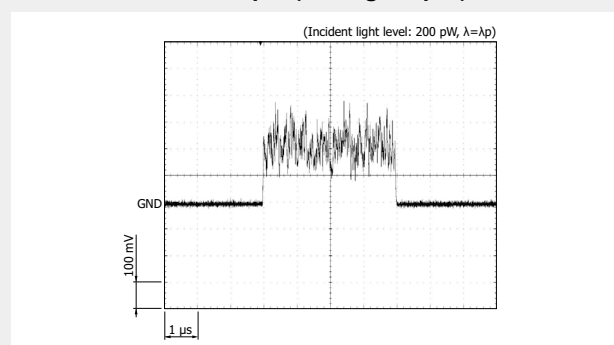
MPPC module C13368-3050EA-16, C13369-3050EA-04

■ Features

- Built-in VIS MPPC array
- Built-in temperature compensation circuit



■ Measurement example (analog output)

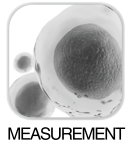


Type no.	Output	Type	Built-in MPPC array			
			Type no.	Number of channels (ch)	Pixel pitch (μm)	Photosensitive area/ch (mm)
C13368-3050EA-16	Analog	Non-cooled	S13363-3050NE-16	1 × 16	50	3.0 × 3.0
C13368-3050EA-04			S13361-3050NE-04	4 × 4	50	3.0 × 3.0

VIS to NIR MPPC

For visible light

S14420 series



MEASUREMENT

FEATURES

- High photon detection efficiency: 40% ($\lambda=600$ nm, $V_{op}=V_{BR} + 5$ V)

APPLICATIONS

- Flow cytometers
- Laser microscopes
- Fluorescence measurement



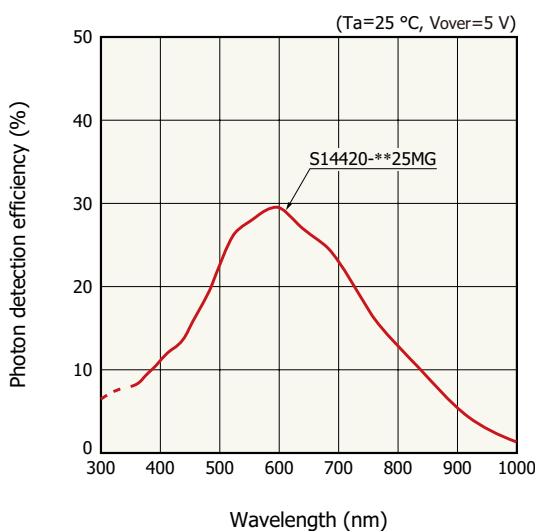
Structure

Type no.		Number of channel (ch)	Package	Pixel pitch (μm)	Effective photosensitive area (mm)	Number of pixels	Fill factor (%)
S14420	-1525MG	1	Metal (TO-5)	25	ϕ 1.5	2876	63
	-1550MG			50		724	81
	-3025MG			25	ϕ 3.0	11344	63
	-3050MG			50		2836	81

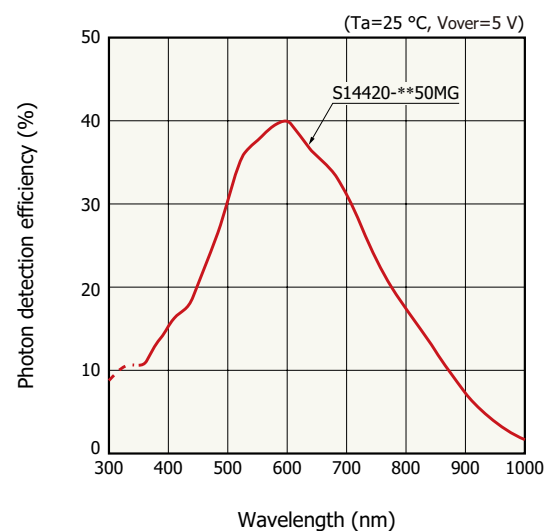
Electrical and optical characteristics (Typ. $T_a=25$ °C , unless otherwise noted)

Type no.		Photon detection efficiency $\lambda=\lambda_p$ (%)	Breakdown voltage (V)	Terminal capacitance (pF)	Dark count	
					Typ. (kcps)	Max. (kcps)
S14420	-1525MG	30	42 ± 5	90	380	1000
	-1550MG	40				
	-3025MG	30		350	1600	4000
	-3050MG	40				

Photon detection efficiency vs. wavelength (typical example)

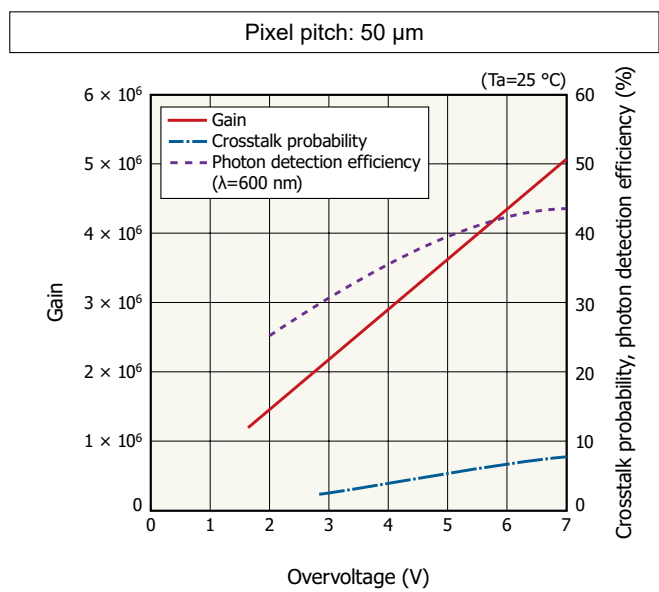
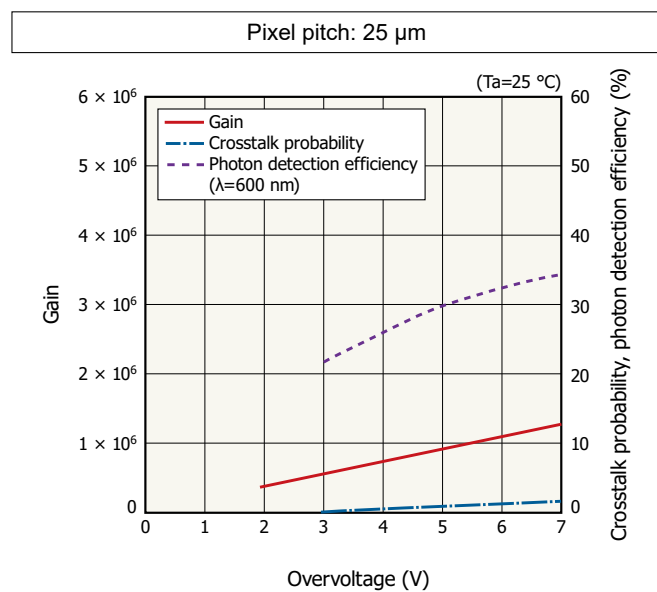
Pixel pitch: 25 μm 

KAPDB0597EB

Pixel pitch: 50 μm 

KAPDB0598EB

■ Gain, crosstalk probability, photon detection efficiency vs. overvoltage (typical example)



► Module type

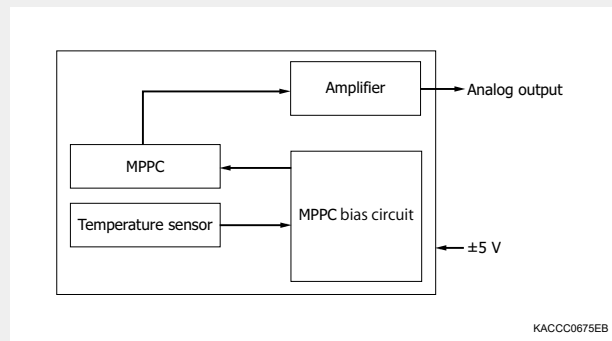
MPPC module C14452 series

■ Features

- Built-in VIS to NIR MPPC (S14420 series)
- Built-in temperature compensation circuit
- Analog output



■ Block diagram

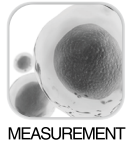


Type no.	Output	Type	Built-in MPPC			
			Type no.	Pixel pitch (μm)	Photosensitive area (mm)	Number of pixels
C14452	Analog	Non-cooled	S14420-1550MG	50	ϕ 1.5	724
			S14420-3050MG		ϕ 3.0	2836

VIS to NIR MPPC

For visible light (cooled type)

S14422 series



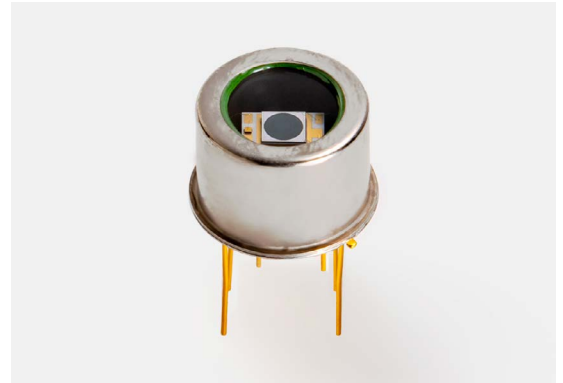
MEASUREMENT

FEATURES

- High photon detection efficiency: 40% ($\lambda=600$ nm, $V_{op}=V_{BR} + 5$ V, 50 μ m pitch)
- Low dark count: 1/10 that of non-cooled type ($T_{chip}=-10$ °C)

APPLICATIONS

- Flow cytometers
- Laser microscopes
- Fluorescence measurement



Structure

Type no.		Number of channel (ch)	Package	Pixel pitch (μ m)	Effective photo-sensitive area (mm)	Number of pixels	Fill factor (%)	Cooling
S14422	-1525DG	1	Metal (TO-8)	25	ϕ 1.5	2876	63	Two-stage TE-cooled
	-1550DG			50		724	81	
	-3025DG			25	ϕ 3.0	11344	63	
	-3050DG			50		2836	81	

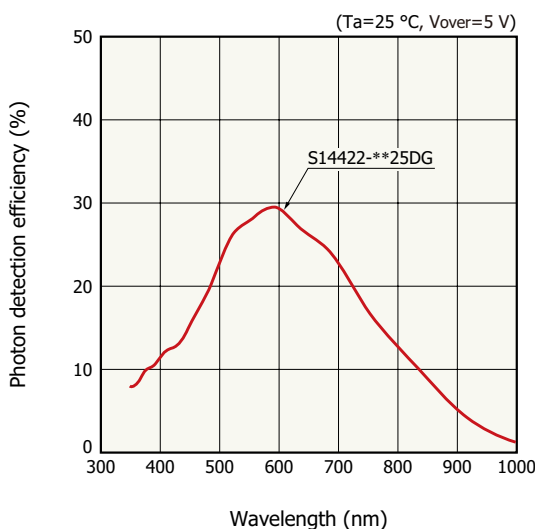
Electrical and optical characteristics (Typ. $T_a=25$ °C , $T_{chip}=-10$ °C , unless otherwise noted)

Type no.		Photon detection efficiency $\lambda=\lambda_p$ (%)	Breakdown voltage (V)	Terminal capacitance (pF)	Dark count		Recommended TE-cooler tempera- ture (°C)	Thermistor resistance (kΩ)	Thermistor B constant (K)
					Typ. (kcps)	Max. (kcps)			
S14422	-1525DG	30	40.5 ± 5	90	20	50	-10	9*1	3410*2
	-1550DG	40							
	-3025DG	30		350	80	200			
	-3050DG	40							

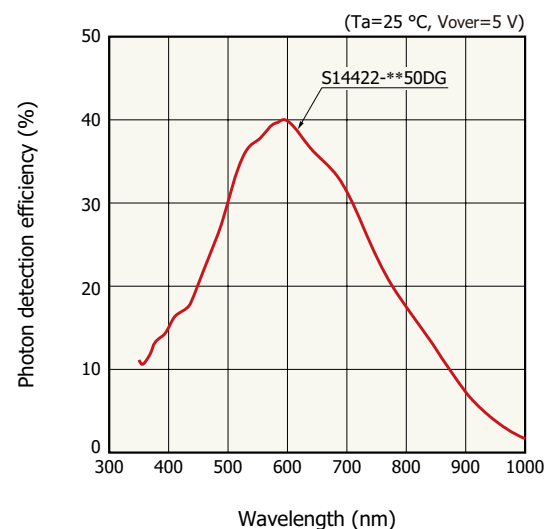
*1: Thermistor temperature=25 °C *2: $T_1=25$ °C, $T_2=50$ °C

Photon detection efficiency vs. wavelength (typical example)

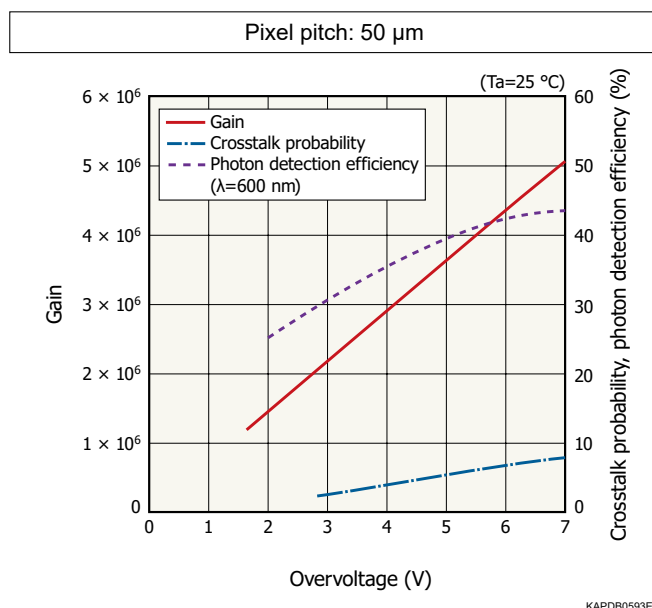
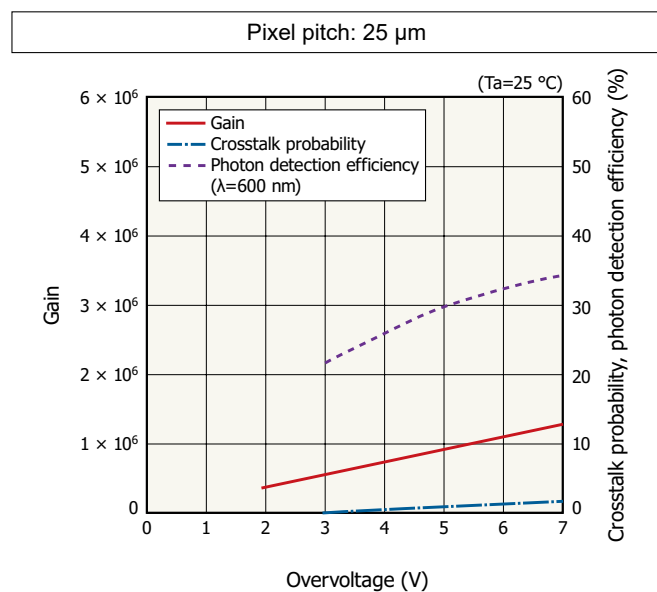
Pixel pitch: 25 μ m



Pixel pitch: 50 μ m



■ Gain, crosstalk probability, photon detection efficiency vs. overvoltage (typical example)



► Module type

MPPC module C14455/C14456 series

■ Features

- Built-in VIS to NIR MPPC (S14422 series: cooled type)
- Built-in temperature control function
- Low dark count
- Compact and lightweight (C14456 series)
- Analog output / digital output types available

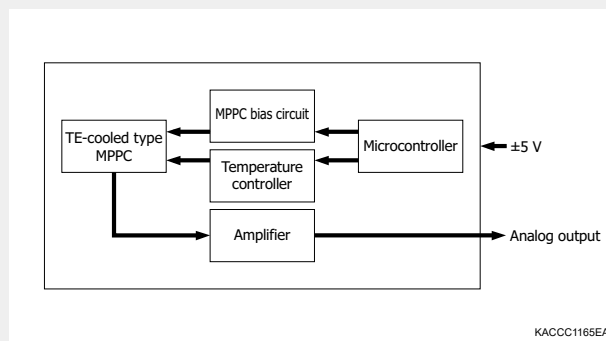


C14455 series
(for evaluation)



C14456 series
(for embedded use)

■ Block diagram (analog output type)



Type no.		Output	Type	Built-in MPPC			
				Type no.	Pixel pitch (μm)	Photosensitive area (mm)	Number of pixels
C14455	-1550GA	Analog	TE-cooled	S14422-1550DG	50	φ 1.5	724
	-3050GA			S14422-3050DG		φ 3.0	2836
	-1550GD	Digital		S14422-1550DG		φ 1.5	724
	-3050GD			S14422-3050DG		φ 3.0	2836
C14456	-1550GA	Analog	TE-cooled	S14422-1550DG	50	φ 1.5	724
	-3050GA			S14422-3050DG		φ 3.0	2836
	-1550GD	Digital	Compact	S14422-1550DG		φ 1.5	724
	-3050GD			S14422-3050DG		φ 3.0	2836

NIR MPPC

For near infrared

S15639-1325PS, S16786-0515WM

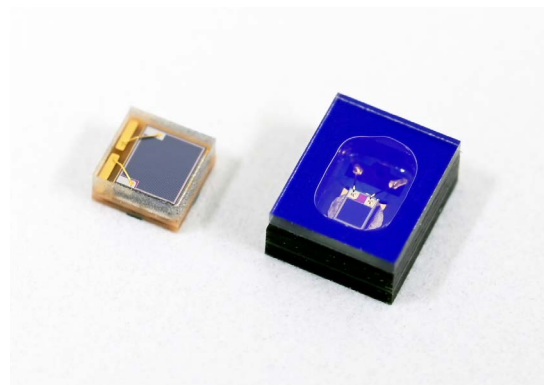


FEATURES

- High photon detection efficiency
- Small package

APPLICATIONS

- Distance measurement (e.g., LiDAR)



Structure

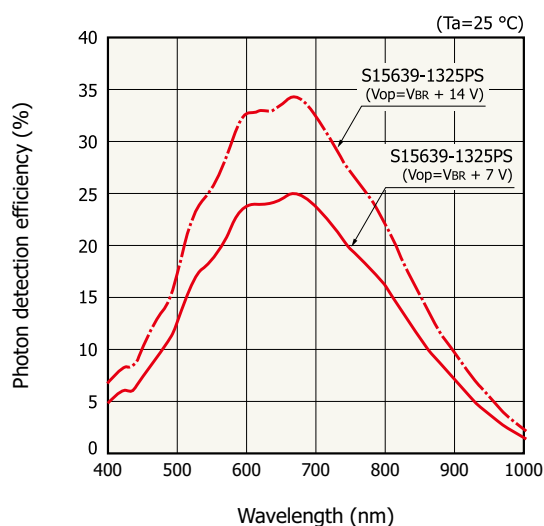
Type no.	Number of channel (ch)	Package	Pixel pitch (μm)	Effective photosensitive area (mm)	Number of pixels
S15639-1325PS	1	Glass epoxy	25	1.1 (H) × 1.3 (V)	2120
S16786-0515WM			15	0.5 (H) × 0.5 (V)	1089

Electrical and optical characteristics (Typ. Ta=25 °C , unless otherwise noted)

Type no.	Photon detection efficiency $\lambda=905\text{ nm}$ $V_R=V_{BR}+14\text{ V}$ (%)	Breakdown voltage (V)	Terminal capacitance (pF)	Dark count	
				Typ. (kcps)	Max. (kcps)
S15639-1325PS	9	42	42	700	2000
S16786-0515WM	15		8	100	500

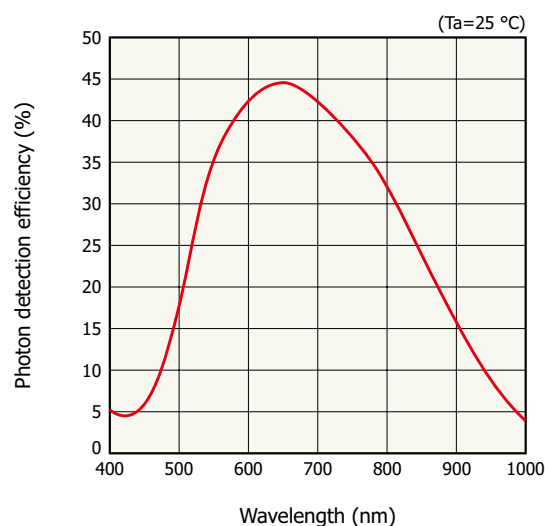
Photon detection efficiency vs. wavelength (typical example)

S15639-1325PS



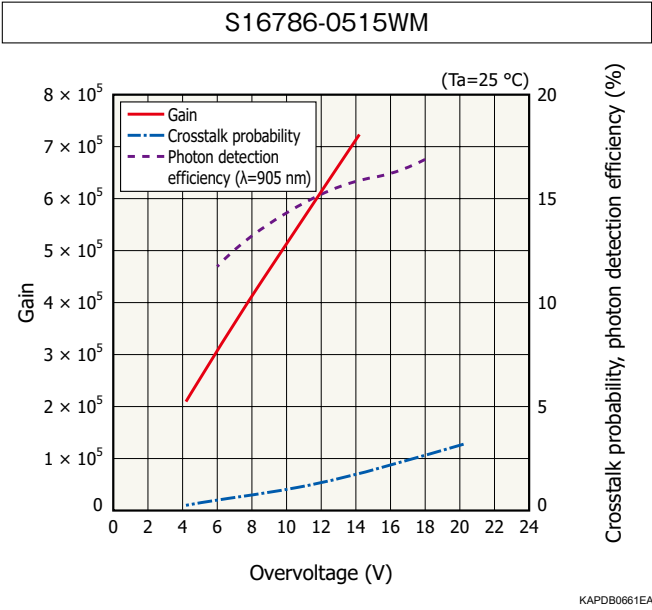
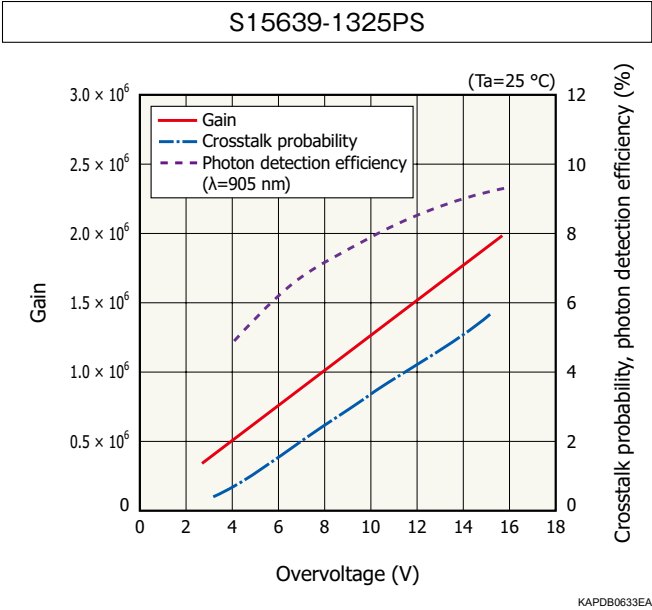
KAPDB0632EB

S16786-0515WM



KAPDB0660EA

■ Gain, crosstalk probability, photon detection efficiency vs. overvoltage (typical example)



Special MPPCs for academic research



VIS MPPC

MPPC for fiber tracker S13552

► FEATURES

- Developed for SciFi tracker in LHCb
- One-dimensional 128-element MPPC array
- Surface mount type

► APPLICATIONS

- High energy physics experiment



■ Structure

Type no.	Number of channels (ch)	Package	Pixel pitch (μm)	Number of pixels / channel	Fill factor (%)
S13552	128 (1 × 64 ch, 2chips)	Glass exopy	57.5 × 62.5	104	78

■ Electrical and optical characteristics (Typ. Ta=25 °C , unless otherwise noted)

Type no.	Photon detection efficiency $\lambda=\lambda_p$ (%)	Breakdown voltage (V)	Terminal capacitance (pF)	Vop variation between channels in one product		Dark count	
				Typ. (V)	Max. (V)	Typ. (kcps)	Max. (kcps)
S13552	47	53 ± 5	320	0.4	1	60	300

VUV/UV MPPC

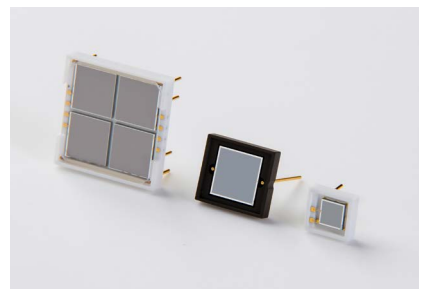
MPPC for dark matter research and neutrino experiments

► FEATURES

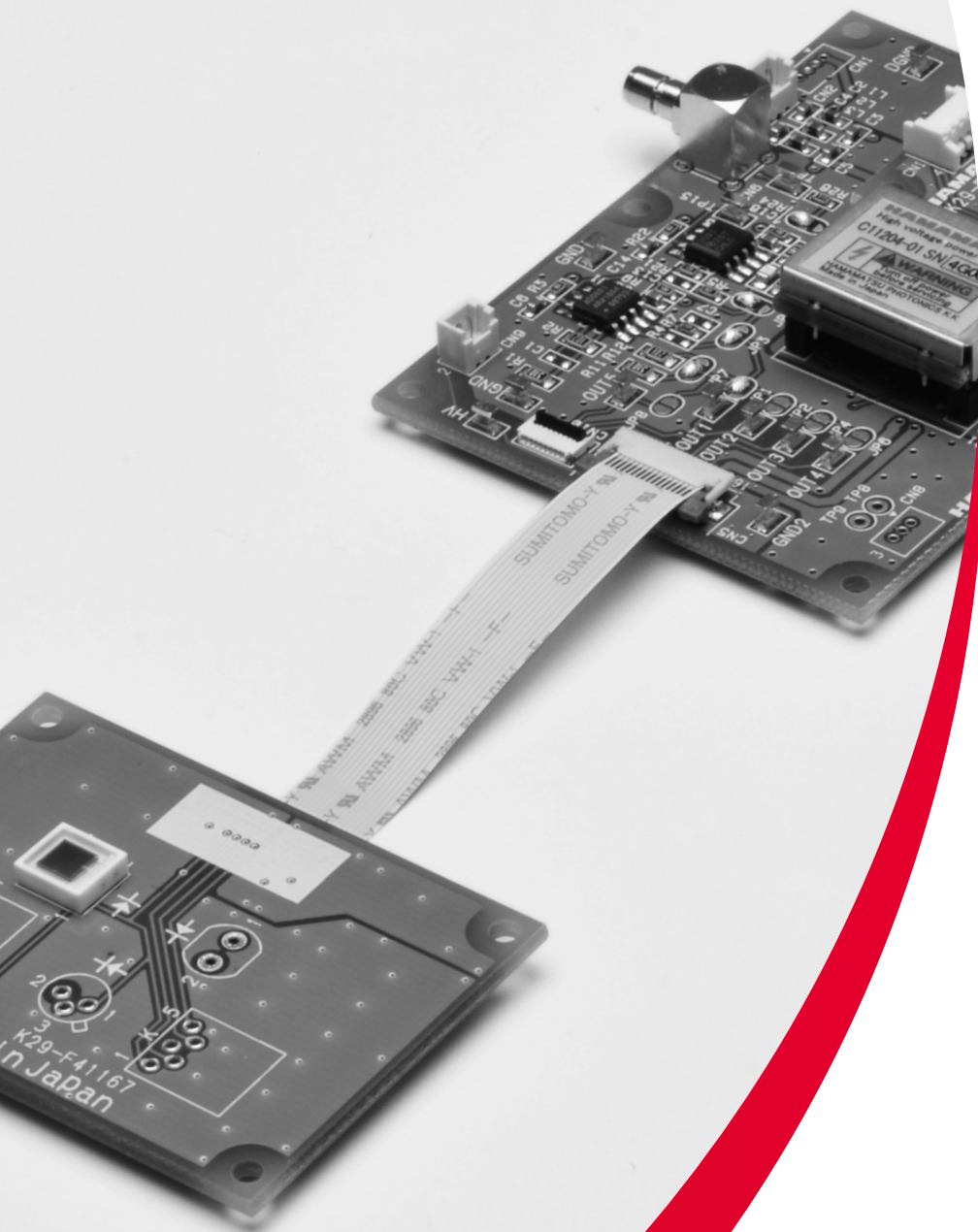
- High sensitivity to scintillation light of liquid xenon and liquid argon
- Suitable operation at cryogenic conditions

► APPLICATIONS

- Scintillation light detection of liquid argon and liquid xenon for academic research experiments



For more details about MPPCs for academic research, please consult us.



Related products

Power supplies for MPPC C11204-01

The C11204-01 is a high-voltage power supply that is optimized for driving MPPCs. Since it has a temperature compensation function, MPPCs can be driven stably even in environments subject to temperature changes.

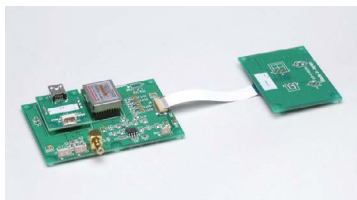


■ Features

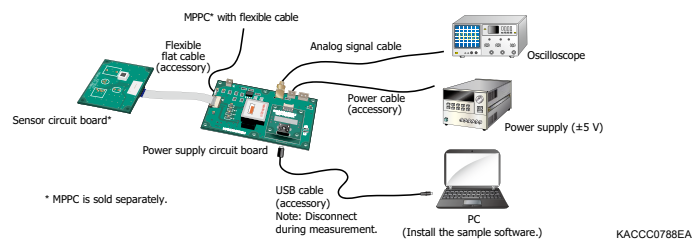
- Superb temperature stability: ± 10 ppm/°C
- Finely adjustable resolution: 1.8 mV steps
- Low ripple noise: 0.1 mVp-p typ.
- Serial interface
- Wide output voltage range: 20 V to 90 V
- Package: Pin type
- Dimensional outline: 19.4(W) × 17.0(H) × 6.3(D) mm

Driver circuits for MPPC

These are driver circuits for evaluating the MPPC. They consist of a power supply circuit board and a sensor circuit board. The power supply circuit board is equipped with a power supply for MPPC (with temperature compensation function). The sensor circuit board has an MPPC socket for leads, which allows MPPCs to be mounted.



■ Connection example



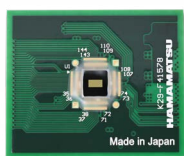
Product name	Photo	Type no.	Compatible MPPC*	Integrated power supply	Output
Driver circuit for MPPC		C12332-02	For non-cooled MPPC (S13360 series)	C11204-01	Analog
		C14450	For non-cooled MPPC (S14420 series)	C11204-01	Analog

* MPPC is sold separately.

Photon counting image sensors (PCI)

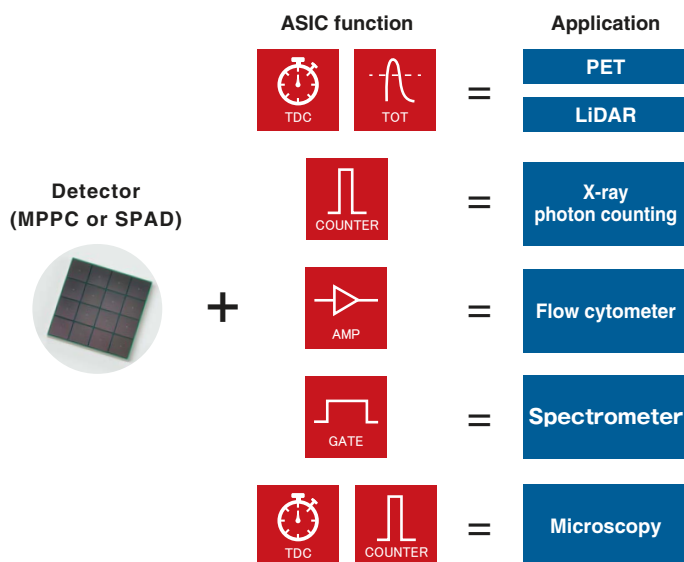
■ Features

- MPPC (or SPAD) and ASIC in 1 package by hybrid connection
- Custom ASIC available for various applications



2D PCI

■ Sensor structure and suitable applications



Please consult us for more details.

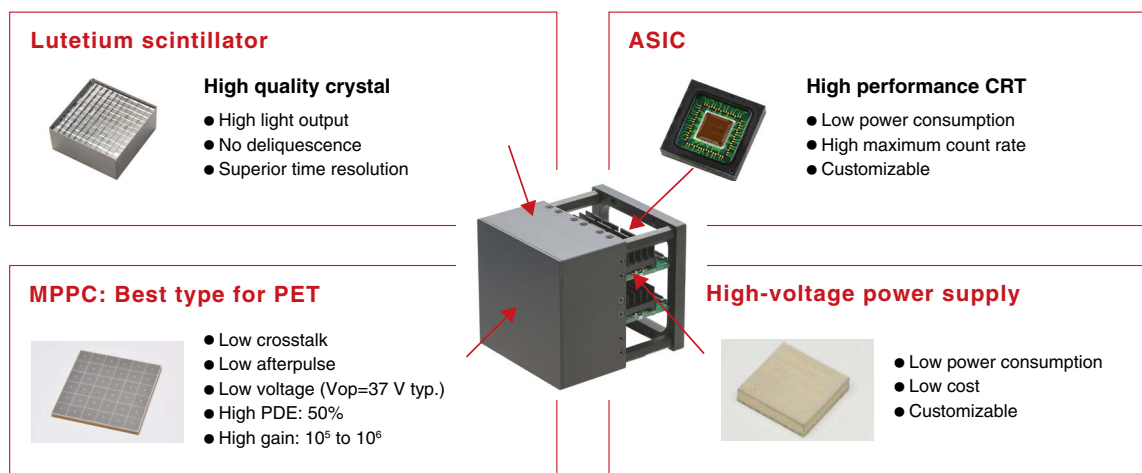
MPPC module for PET C13500 series

■ Features

- Built-in VIS MPPC (S14160 series)
- Included functions necessary for TOF-PET
- Timing resolution (FWHM): 210 ps
- Built-in temperature compensation circuit
- Digital interface: high-speed serial



■ Structure



SPAD S16835 series



■ Features

- Low dark count
- Low afterpulse
- High photon detection efficiency: 67% typ.
- High gain: 10^6 to 10^7 typ.

■ Applications

- Flow cytometry
- Fluorescence measurement

■ Structure

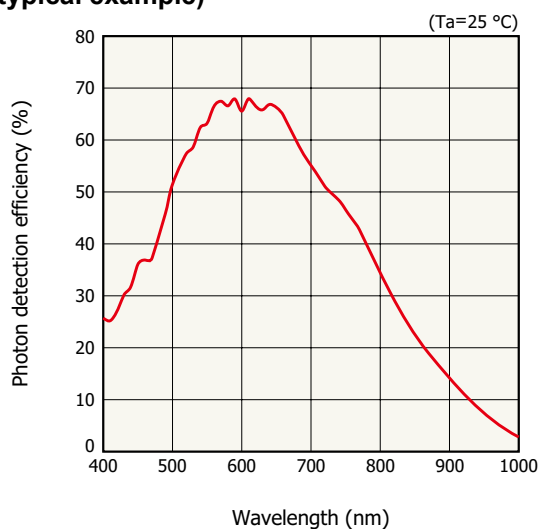
Type no.		Effective photosensitive area (μm)	Number of pixel	Package	Cooling
S16835	-050DG	$\Phi 54$	1	Metal (TO-8)	Two-stage TE-cooling
	-100DG	$\Phi 100$			

■ Electrical and optical characteristics (Typ. $T_a=25\text{ }^\circ\text{C}$, $T_{\text{chip}}=-10\text{ }^\circ\text{C}$ unless otherwise noted)

Type no.		Photon detection efficiency* $\lambda=\lambda_p$ (%)	Breakdown voltage (V)	Terminal capacitance (pF)	Gain	Dark count	
						Typ. (kcps)	Max. (kcps)
S16835	-050DG	67	40 ± 5	2.8	6.0×10^6	0.015	0.06
	-100DG			3.2	1.5×10^7	0.05	0.2

* Photon detection efficiency includes afterpulse.

■ Photon detection efficiency vs. wavelength (typical example)



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SPAD modules

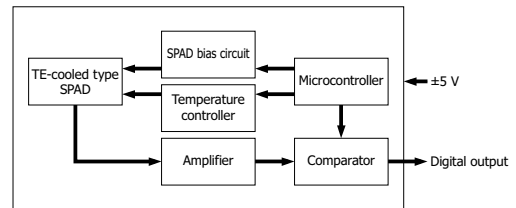
Photon counting modules that can detect extremely low-level light. It consists of a TE-cooled SPAD (single photon avalanche diode), amplifier, comparator, bias circuit, and temperature controller. You can simply supply external power (± 5 V) to use these modules.

* For more details about SPAD, see P.33









■ Features

- High sensitivity
- Extremely low dark count: 7 cps typ. (VIS type)
- Low afterpulse
- Built-in temperature control function
- Digital output

■ Block diagram



KACCC1167EA

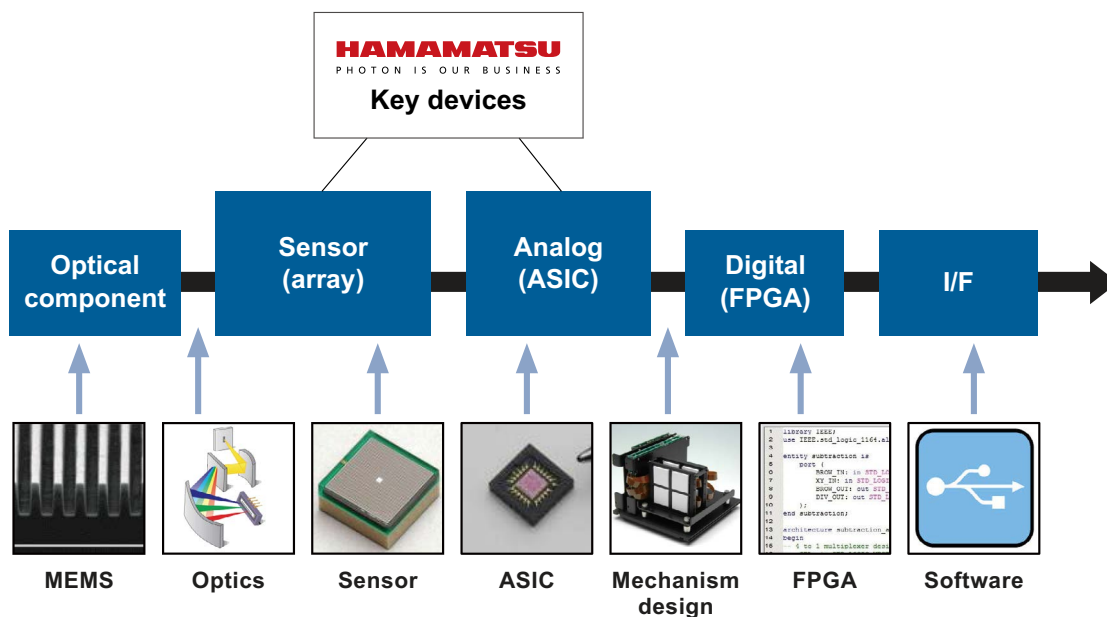
Product name	Photo	Type no.	Built-in sensor	Photosensitive area size (μm)	Spectral response range (nm)	Output	Type
VIS SPAD modules		C11202-050	TE-cooled SPAD	φ50	320 to 900	Digital	-
		C11202-100		φ100	320 to 900		-
		C13001-01		-	370 to 900		Fiber coupling
		C14076-01		-	370 to 900		Fiber coupling Embedded use
VIS to NIR SPAD modules		C16531-050GD		φ54	400 to 1000	Digital	-
		C16531-100GD		φ100	400 to 1000		-
		C16533-050GD		-	400 to 1000		Fiber coupling
		C16534-050GD		-	400 to 1000		Fiber coupling Embedded use

Customized modules

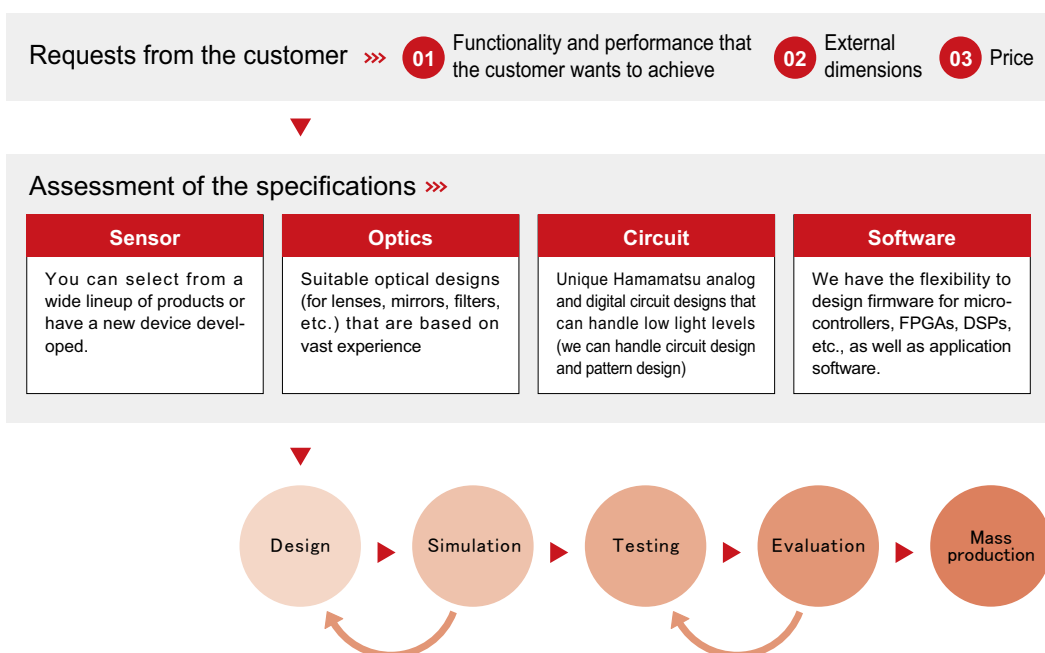
Hamamatsu can provide the most suitable module product by combining its vast sensor lineup with optical technologies, circuit technologies, and software technologies.

■ Hamamatsu flexibility

We offer customization by combining elemental technologies. Each key component suitable for an application can be selected, and compactly integrated in a small module.



■ Process for developing a custom module



Operating principle of MPPC

Photon counting

Light has the properties of both a particle and a wave. When the light level becomes extremely low, light behaves as discrete particles (photons) allowing us to count the number of photons. Photon counting is a technique for measuring the number of individual photons.

The MPPC is suitable for photon counting since it offers an excellent time resolution and a multiplication function having a high gain and low noise. Compared to ordinary light measurement techniques that measure the output current as analog signals, photon counting delivers a higher S/N and higher stability even in measurements at very low light levels.

Geiger mode and quenching resistor

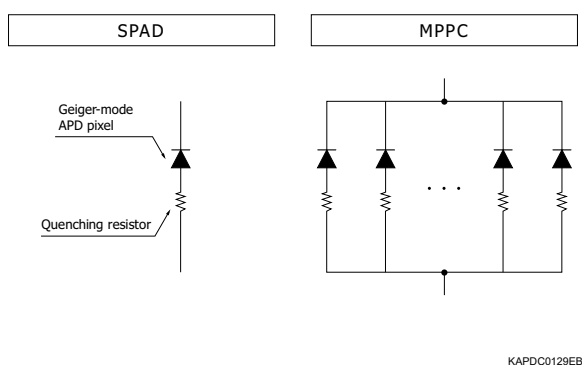
When an APD is operated at a reverse voltage higher than its breakdown voltage, a saturated output inherent to the APD device occurs (Geiger discharge) by input of light regardless of whether the light level is high or low. The condition where an APD operates at this voltage level is called Geiger mode. Geiger mode allows obtaining a large output by way of discharge even when detecting a single photon. Once Geiger discharge begins, it continues for as long as the electric field in the APD is maintained. To halt a Geiger discharge and detect the next photon, an external circuit outside the APD must lower the operating voltage. One specific example for halting the Geiger discharge is a technique using a so-called quenching resistor connected in series with the APD. This quickly stops avalanche multiplication in the APD because a drop in the operating voltage occurs when the output current caused by the Geiger discharge flows in the quenching resistor. The output current caused by Geiger discharge is a pulse waveform with a sharp rise time, while the output current when Geiger discharge is halted by the quenching resistor is a pulse waveform with a relatively slow fall time.

Configuration

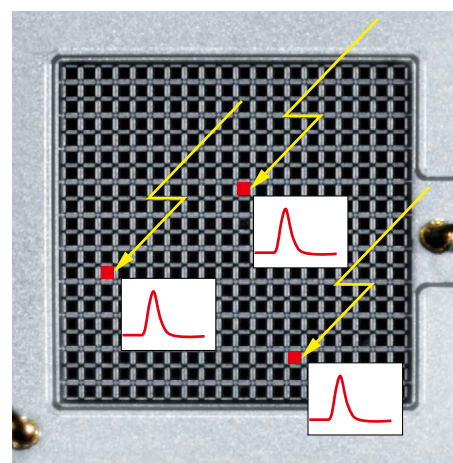
The structures of SPAD and MPPC are shown below.

SPAD is configured with one pixel, in which a Geiger mode APD and a Quenching resistor are combined as one set. MPPC is configured with a plurality of pixels, in which said SPADs are arranged in plural numbers and electrically connected in parallel.

■ Configuration of SPAD and MPPC



■ Illustration of an MPPC counting photons



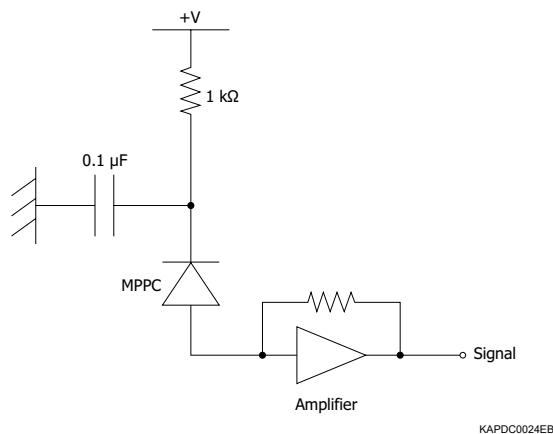
Basic operation

Each pixel in the MPPC outputs a pulse at the same amplitude when it detects a photon. Pulses generated by multiple pixels are output while superimposed onto each other. For example, if four photons are incident on different pixels and detected at the same time, then the MPPC outputs a signal whose amplitude equals the height of the four superimposed pulses.

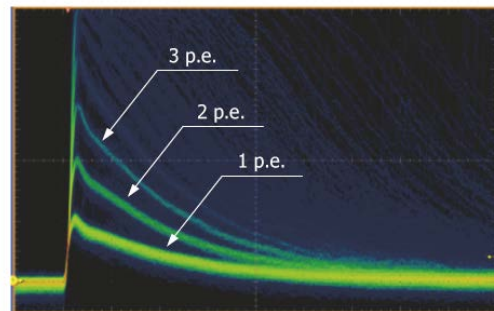
Each pixel outputs only one pulse and this does not vary with the number of incident photons. So the number of output pulses is always one regardless of whether one photon or two or more photons enter a pixel at the same time. This means that MPPC output linearity gets worse as more photons are incident on the MPPC such as when two or more photons enter one pixel. This makes it essential to select an MPPC having enough pixels to match the number of incident photons.

For the MPPC readout circuit, a current-to-voltage amplifier can be used as with previous semiconductor devices. The MPPC outputs high-speed pulse signals, but because the gain of the MPPC itself is high, there is no need to greatly increase the gain on the circuit side. This has the advantage of more freedom in circuit design.

■ Basic connection diagram



■ Pulse waveforms when using a linear amplifier



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Information described in this material is current as of June 2025.

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